

P-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^d	Q _g (Typ.)			
- 40	0.020 at V _{GS} = - 10 V	-10.5	22 nC			
- 40	0.029 at V _{GS} = - 4.5 V	-8.5	22110			

FEATURES

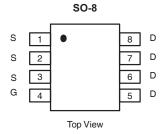
- DT-Trench Power MOSFET
- $\bullet\,$ 100 % R_g and UIS Tested

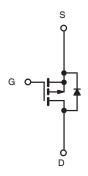
APPLICATIONS

- Power management
- Load switch
- Battery protection



RoHS





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $(T_A = 2)$	25 °C, unless other	wise noted)			
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-source voltage	V_{DS}	-40			
Gate-source voltage		V_{GS}	± 20	V	
	T _C = 25 °C		-10.5		
Continuous drain surrent (T = 150 °C)	T _C = 70 °C		-7.8		
Continuous drain current (T _J = 150 °C)	T _A = 25 °C	- I _D	-6.5 ^{a, b}		
	T _A = 70 °C		-4.3 ^{a, b}		
Pulsed drain current		I _{DM}	-40	А	
Continuous source-drain diode current	T _C = 25 °C	1	-10		
Continuous source-drain diode current	T _A = 25 °C	- I _S	-4.1 ^{a, b}		
Avalanche current	L = 0.1 mH	I _{AS}	- 7.9		
Single-pulse avalanche energy	L = 0.1 MH	E _{AS}	7.5	mJ	
	T _C = 25 °C		7.3		
Maximum navvar dissination	T _C = 70 °C	T _C = 70 °C	4.7	w	
Maximum power dissipation	T _A = 25 °C	P _D	2.2 ^{a, b}]	
	T _A = 70 °C]	1. 4 ^{a, b}		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient a, c	t ≤ 10 s	R _{thJA}	35	53	°C/W	
Maximum junction-to-foot	Steady state	R _{thJF}	20	30	C/VV	

Notes

- a. Surface mounted on 1" x 1" FR4 board
- b. t = 10 s
- c. Maximum under steady state conditions is 85 °C/W
- d. Based on $T_C = 25$ °C



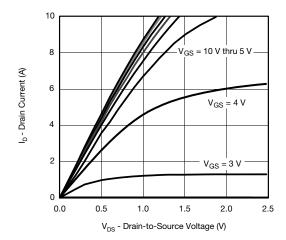
PARAMETER	SYMBOL TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-40	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	-42	-	mV/°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = -250 \mu A$	-	4.6	-		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-1	-	-3	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
Zava gota valtaga dvain avvvant	,	V _{DS} = -40 V, V _{GS} = 0 V	-	-	-1		
Zero gate voltage drain current	I _{DSS}	V _{DS} = -32 V, V _{GS} = 0 V, T _J = 55 °C	5		μA		
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	-10	-	-	Α	
Dualin annuar an atata unaistana 2	Б	$V_{GS} = -10 \text{ V}, I_D = -5 \text{ A}$	-	0.020	0.030	Ω	
Drain-source on-state resistance ^a	R _{DS(on)}	V _{GS} = -4.5 V, I _D = -4 A	-	0.029	0.045		
Forward transconductance a	9 _{fs}	$V_{DS} = -10 \text{ V}, I_D = -5 \text{ A}$	-	24	-	S	
Dynamic ^b			<u> </u>				
Input capacitance	C _{iss}		-	1987	-	pF	
Output capacitance	C _{oss}	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	256	-		
Reverse transfer capacitance	C _{rss}		-	105	-		
Total gata abaysa	Qg	$V_{DS} = -20 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -5 \text{ A}$	- 39 -		-		
Total gate charge			-	22	-		
Gate-source charge	Q_{gs}	$V_{DS} = -20 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -4 \text{ A}$		7	-	nC	
Gate-drain charge	Q_{gd}		-	10	-	1	
Gate resistance	R_{g}	f = 1 MHz	-	5	-	Ω	
Turn-on delay time	t _{d(on)}		-	13	-		
Rise time	t _r	$V_{DD} = -20 \text{ V}, R_{I} = 4 \Omega$	-	19	-		
Turn-off delay time	t _{d(off)}	$I_D \cong -5 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$	-	33	-	- ns	
Fall time	t _f		-	9	-		
Drain-Source Body Diode Characteris	tics		<u> </u>				
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	-10.5		
Pulse diode forward current	I _{SM}		-	-	-40	A	
Body diode voltage	V _{SD}	I _S = -2 A, V _{GS} = 0 V	-	-0.7	-1.2	V	
Body diode reverse recovery time	t _{rr}		-	42	-	ns	
Body diode reverse recovery charge	Q _{rr}			23	-	nC	
Reverse recovery fall time	ta	T _J = 25 °C	-	17	-	ns	
Reverse recovery rise time	t _b		-	15	_		

Notes

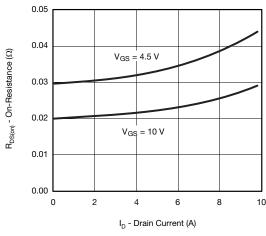
- a. Pulse test; pulse width $\leq 300 \ \mu s$, duty cycle $\leq 2\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

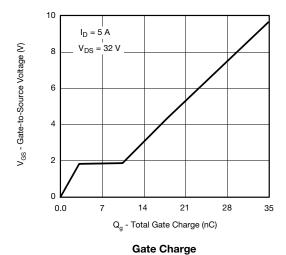


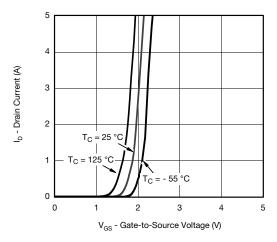


Output Characteristics

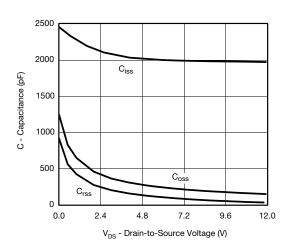


On-Resistance vs. Drain Current

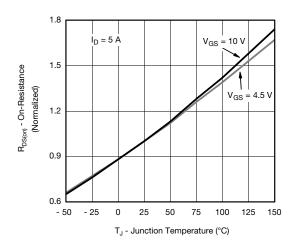




Transfer Characteristics

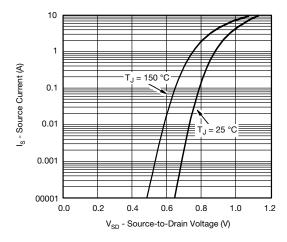


Capacitance

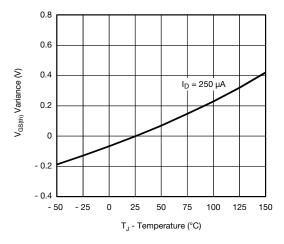


On-Resistance vs. Junction Temperature

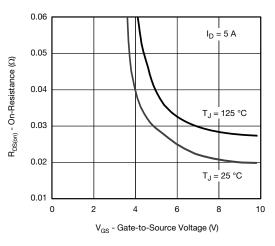




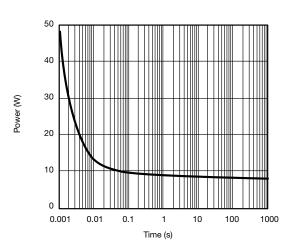
Source-Drain Diode Forward Voltage



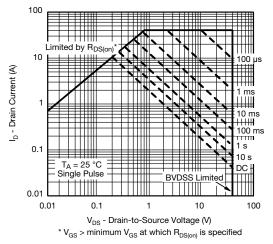
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

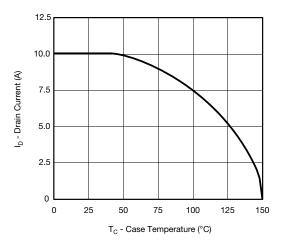


Single Pulse Power, Junction-to-Ambient

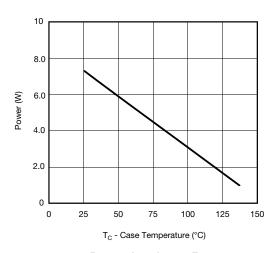


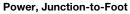
Safe Operating Area

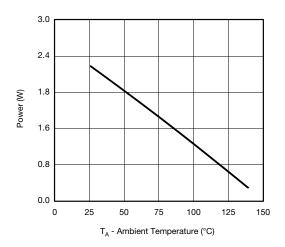




Current Derating a





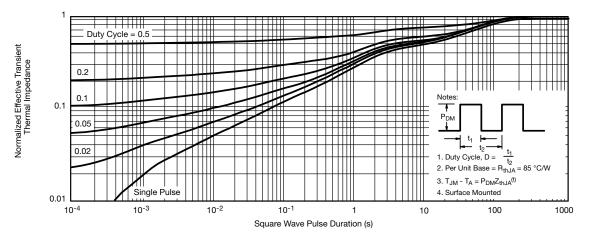


Power Derating, Junction-to-Ambient

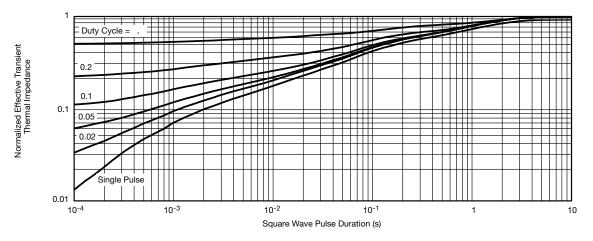
Note

a. The power dissipation P_D is based on T_U max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

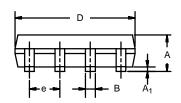


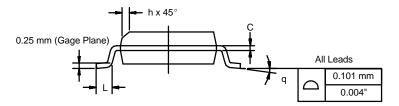
Din-Tek

SEMICONDUCTOR

SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







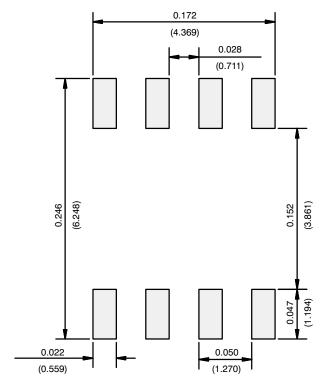
	MILLIM	IETERS	INC	HES	
DIM	Min	Max	Min	Max	
Α	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27	BSC	0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
FCN: C-06527-Rev I 11-Sen-06					

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)





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